INFORMATION STATEMENT

Docket: EWG-143L

Ser. No.: 09/826,616

Applicant: Hugh Anglin Filed: April 5, 2001 Group: 2624

		US Patent Doc	uments		
Ex'r Initial	Number	Date	Inventor	Class	
Oper					
17	5200822	4/6/93	Bronfin et al.	725/22	
7	5636292	6/3/97	Rhoads	382/232	
7	5710834	1/20/98	Rhoads	382/232	
$\overline{}$	5721788	5/24/98	Powell et al.	382/100	
	5748783	5/5/98	Rhoads	382/232	
$\neg \tau$	5768426	6/16/98	Rhoads	382/232	
1,	5841978	11/24/98	Rhoads	709/217	
N	6122403	9/19/00	Rhoads	382/233	
Jas	6332031	12/18/01	Rhoads et al.	382/100	
Wis	6512837	1/28/03	Ahmed	382/100	
gas	6694041	2/17/04	Brunk	382/100	
W.	20020076084	6/20/02	Tian et al.	382/100	
yer	20020085238	7/4/02	Umeda	358/3.28	
JUZ-	20040202348	1/14/04	Kuzma	382/100	
ger	09/731,456	12/6/00	Levy et al.	380/252	
U	<u> </u>	Foreign Patent D	ocuments		
Ex'r Initial	Number	Date	Country	Class	
(m)	WO00/70585	11/23/00	PCT	609C 5100	
		Other Refere	ences		
Ex'r Initial			Cite	······································	
gie	Bender et al., "Applicat 568.	ions for Data Hiding," IBM	Systems Journal, Vol. 39, Nos.	3&4, 2000, pp. 547-	
as	"Proposal of an Objective Picture Quality Measurement Method with a Reduced Reference Using Invisible Marker Signals," 8 pages, March, 2001				
/					

	Date Considered:
Mugh Troping	6/14/2005
Examiner: Initial if considered, whether or not in conforma	nce with MPEP 609; draw line through cite if
not in conformance and not considered. Include conv. of this	form with next communication to applicant

MAR 0 4 2015 a

INFORMATION
DISCLOSURE
STATEMENT

Docket:	EWG-143L	S

Ser. No.: 09/826,616

Applicant: Hugh Anglin Filed: April 5, 2001

led: April 5, 2001 Group: 2624

US Patent Documents					
Ex'r Initial	Number	Date	Inventor	Class	
<u> </u>					
				+	
			,		
		Foreign Patent D	Occuments		
Ex'r Initial	Number	Date	Country	Class	
		Other Refer	ences	1	
Ex'r Initial			Cite		
	NCITS-W1 99-01	24 IS 13660 Proof, ISO/IEC 136			
1		<u> </u>			
				·	

Examiner Signature: Examiner: Initial if considered, whether or not in conforma	Date Considered: 6/14/2005
Examiner: Initial if considered, whether or not in conforma	nce with MPEP 609; draw line through cite if
not in conformance and not considered. Include copy of this	form with next communication to applicant.